GD75MPS17-CAL
1700V 75A SiC Schottky MPS™ Diode

Silicon Carbide Schottky Diode

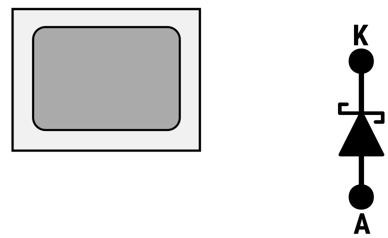
For physical chip dimensions please contact engineering@diedevices.com

V_{RRM}	=	1700 V
I_F (T_C = 127°C)	=	75 A
Q_C	=	524 nC

Features

- Gen4 Thin Chip Technology for Low V_F
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Q_C/I_F
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V_F
- Low V_F for High Temperature Operation

Bare Chip



RoHS

REACH

Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Improved System Efficiency

Applications

- EV Fast Chargers
- Solar Inverters
- Wind Energy Converters
- Train Auxiliary Power Supplies
- High Frequency Rectifiers
- Switched Mode Power Supplies
- Motor Drives
- Pulsed Power

Absolute Maximum Ratings (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V_{RRM}		1700	V	
Continuous Forward Current	I_F	T_C = 100°C, D = 1 T_C = 135°C, D = 1 T_C = 127°C, D = 1	97 67 75	A	
Non-Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,SM}$	T_C = 25°C, t_P = 10 ms T_C = 150°C, t_P = 10 ms	750 600	A	
Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,RM}$	T_C = 25°C, t_P = 10 ms T_C = 150°C, t_P = 10 ms	450 315	A	
Non-Repetitive Peak Forward Surge Current	$I_{F,MAX}$	T_C = 25°C, t_P = 10 µs	3750	A	
i^2t Value	$\int i^2 dt$	T_C = 25°C, t_P = 10 ms	2812	A^2s	
Non-Repetitive Avalanche Energy	E_{AS}	L = 0.5 mH, I_{AS} = 75 A	1270	mJ	
Diode Ruggedness	dV/dt	V_R = 0 ~ 1360 V	200	V/ns	
Power Dissipation	P_{TOT}	T_C = 25°C	556	W	
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C	

**Assumes Thermal Resistance, Junction - Case (R_{thJC}) of 0.27°C/W*

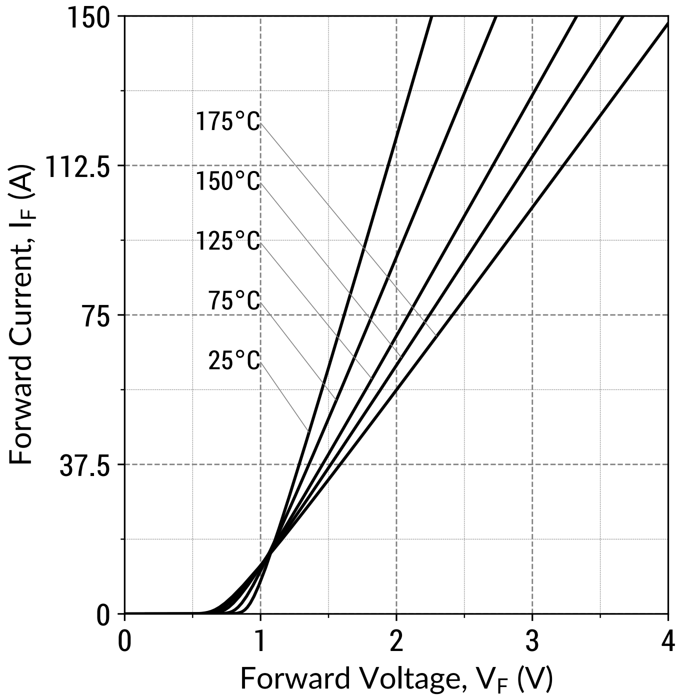
Electrical Characteristics

Parameter	Symbol	Conditions		Values		Unit	Note
			Min.	Typ.	Max.		
Diode Forward Voltage	V_F	I_F = 75 A, T_j = 25°C I_F = 75 A, T_j = 175°C		1.6 2.4	1.8	V	Fig. 1
Reverse Current	I_R	V_R = 1700 V, T_j = 25°C V_R = 1700 V, T_j = 175°C		2 41	10	μA	Fig. 2
Total Capacitive Charge	Q_C	$I_F \le I_{F,MAX}$, dI_F/dt = 200 A/μs; V_R = 600 V V_R = 1200 V		358 524		nC	Fig. 4
Switching Time	t_S	$I_F \le I_{F,MAX}$, dI_F/dt = 200 A/μs; V_R = 600 V V_R = 1200 V		< 10		ns	
Total Capacitance	C	V_R = 1 V, f = 1MHz V_R = 1200 V, f = 1MHz		4577 252		pF	Fig. 3

Mechanical Parameters

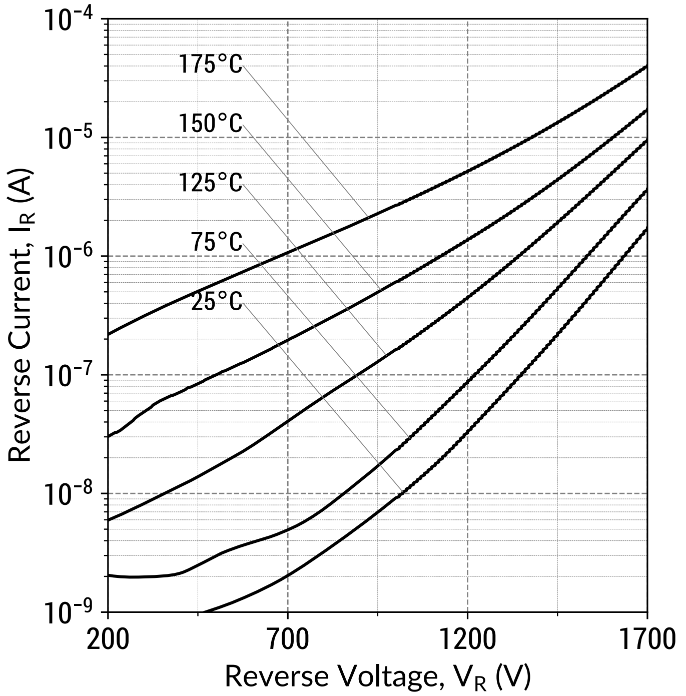
This information is confidential, please contact **sales@genesicsemi.com** to learn more.

Figure 1: Typical Forward Characteristics



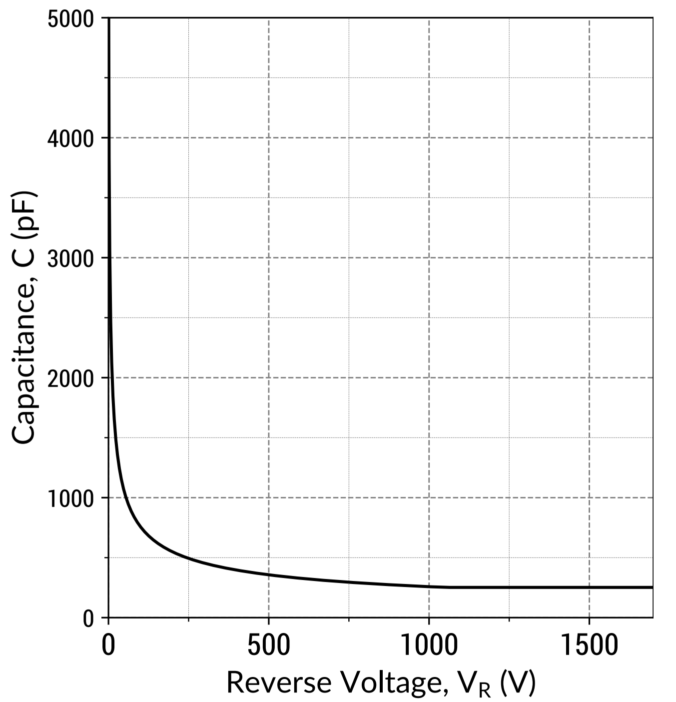
$I_F = f(V_F,T_j)$; t_P = 250 µs

Figure 2: Typical Reverse Characteristics



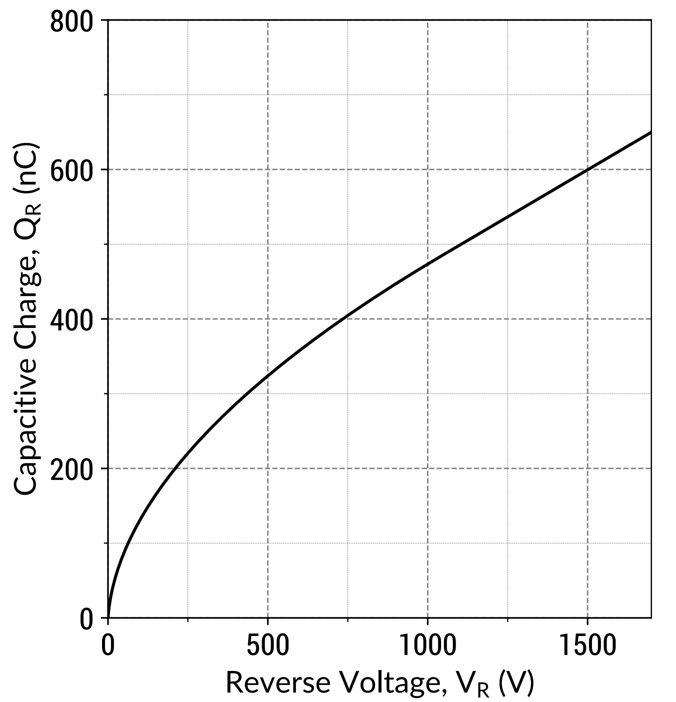
$I_R = f(V_R,T_j)$

Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics



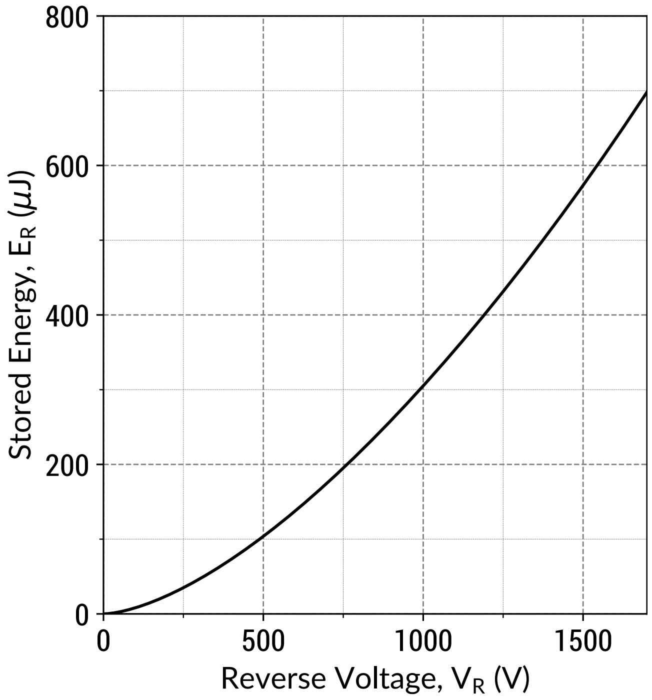
$C = f(V_R)$; f = 1MHz

Figure 4: Typical Capacitive Charge vs Reverse Voltage Characteristics



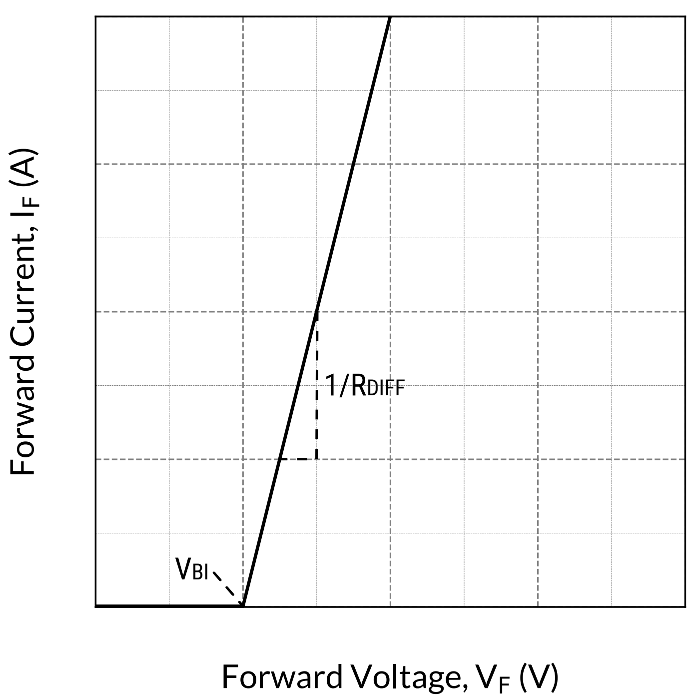
$Q_C = f(V_R)$; f = 1MHz

Figure 5: Typical Capacitive Energy vs Reverse Voltage Characteristics



$E_C = f(V_R)$; f = 1MHz

Figure 6: Forward Curve Model



$I_F = f(V_F, T_j)$

Forward Curve Model Equation:

$I_F = (V_F - V_{BI})/R_{DIFF}$ (A)

Built-In Voltage (V_{BI}):

$V_{BI}(T_j) = m \times T_j + n$ (V)

m = -0.00125 (V/°C)

n = 1.0 (V)

Differential Resistance (R_{DIFF}):

$R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c$ (Ω)

a = 1.61e-07 (Ω/°C²)

b = 5.53e-05 (Ω/°C)

c = 7.14e-03 (Ω)

Forward Power Loss Equation:

$P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$

Chip Dimensions

This information is confidential, please contact **sales@genesicsemi.com** to learn more.

NOTE

1. CONTROLLED DIMENSION IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.

Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

- SPICE Models: https://www.genesicsemi.com/sic-schottky-mps/GD75MPS17-CAL/GD75MPS17-CAL_SPICE.zip
- PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GD75MPS17-CAL/GD75MPS17-CAL_PLECS.zip
- CAD Models: https://www.genesicsemi.com/sic-schottky-mps/GD75MPS17-CAL/GD75MPS17-CAL_3D.zip
- Evaluation Boards: https://www.genesicsemi.com/technical-support
- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

Revision History

Date	Revision	Comments	Supersedes
07/09/2020	Rev 1	Initial Release	

www.genesicsemi.com/sic-schottky-mps/

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